







TMUX7236

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TMUX7236 具有闩锁效应抑制和 1.8V 逻辑电平的 44V、低 RON、2:1 (SPDT)、双 通道精密开关

1 特性

闩锁效应抑制 •

TEXAS

INSTRUMENTS

- 双电源电压范围: ±4.5 V 至 ±22 V
- 单电源电压范围:4.5 V 至 44 V
- 低导通电阻:2Ω
- 高电流支持: 330 mA (最大值) (WQFN)
- 40°C 至 +125°C 工作温度 •
- 兼容 1.8 V 逻辑电平
- 逻辑引脚上具有集成的下拉电阻器
- 失效防护逻辑
- 轨至轨运行
- 双向运行

2 应用

- 燃气表 ٠
- 流量变送器
- 工厂自动化和工业控制
- 可编程逻辑控制器 (PLC)
- 模拟输入模块
- 半导体测试
- 数据采集系统
- 超声波扫描仪
- 光纤网络
- 光学测试设备
- 远程无线电单元
- 有线网络 ٠
- 患者监护和诊断

3 说明

TMUX7236 是一款具有闩锁效应抑制特性的互补金属 氧化物半导体 (CMOS) 开关,采用双通道 2:1 配置。 该器件在双电源(±5V 至 ±22V)、单电源(5V 至 44V) 或非对称电源(例如 V_{DD} = 12V, V_{SS} = -5V) 供电时均能正常运行。TMUX7236 可在源极 (Sx) 和漏 极 (D) 引脚上支持从 Vss 到 VDD 范围的双向模拟和数 字信号。

所有逻辑控制输入均支持 1.8V 到 VDD 的逻辑电平,当 器件在有效电源电压范围内运行时,可实现 TTL 和 CMOS 逻辑兼容性。失效防护逻辑电路允许先在控制 引脚上施加电压,然后在电源引脚上施加电压,从而保 护器件免受潜在的损害。

TMUX72xx 系列具有闩锁效应抑制特性,可防止器件 内寄生结构之间通常由过压事件引起的大电流不良事 件。闩锁状态通常会一直持续到电源轨关闭为止,并可 能导致器件故障。闩锁效应抑制特性使得 TMUX72xx 系列开关和多路复用器能够在恶劣的环境中使用。

| 事 | 装 | 信 | 息 |
|------------|-----|---|----------------|
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| | e a ce a line real. | |
|----------|---------------------|---------------------|
| 器件型号 | 封装 ⁽¹⁾ | 封装尺寸 ⁽²⁾ |
| TMUX7236 | RUM (WQFN, 16) | 4mm × 4mm |
| | PW(TSSOP,16) | 5mm × 6.4mm |

(1)有关详细信息,请参阅节11。

(2) 封装尺寸(长×宽)为标称值,并包括引脚(如适用)。

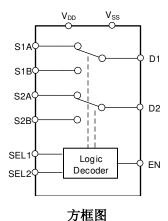






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4 Pin Configuration and Functions

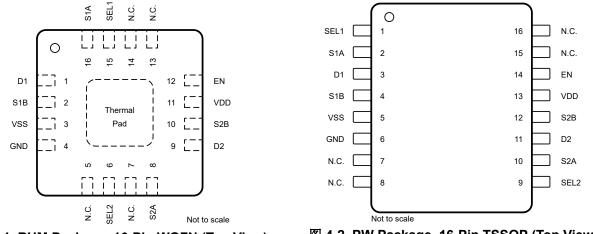


图 4-1. RUM Package, 16-Pin WQFN (Top View)



| | PIN | | TYPE ⁽¹⁾ | DECODIDITION |
|-----------------|-------------|--------------|---------------------------------------|---|
| NAME | TSSOP | WQFN | ITPE(" | DESCRIPTION |
| | | I/O | Drain pin. Can be an input or output. | |
| D2 | 11 | 9 | I/O | Drain pin. Can be an input or output. |
| GND | 6 | 4 | Р | Ground (0 V) reference |
| NC | 7, 8, 15,16 | 5, 7, 13, 14 | _ | No internal connection. Can be shorted to GND or left floating. |
| S1A | 2 | 16 | I/O | Source pin 1A. Can be an input or output. |
| S1B | 4 | 2 | I/O | Source pin 1B. Can be an input or output. |
| S2A | 10 | 8 | I/O | Source pin 2A. Can be an input or output. |
| S2B | 12 | 10 | I/O | Source pin 2B. Can be an input or output. |
| EN | 14 | 12 | I | Active high logic enable, has internal pull-up resistor. When this pin is low, all switches are turned off. When this pin is high, the SEL logic input determine which switch is turned on. |
| SEL1 | 1 | 15 | I | Logic control input, has internal pull-down resistor. Controls the switch connection as shown in $\#$ 7.4. |
| SEL2 | 9 | 6 | I | Logic control input, has internal pull-down resistor. Controls the switch connection as shown in \ddagger 7.4. |
| V _{DD} | 13 | 11 | Р | Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 μ F to 10 μ F between V _{DD} and GND. |
| V _{SS} | 5 | 3 | Ρ | Negative power supply. This pin is the most negative power-supply potential. In single-supply applications, this pin can be connected to ground. For reliable operation, connect a decoupling capacitor ranging from 0.1 μ F to 10 μ F between V _{SS} and GND. |
| Thermal Pa | ad | | — | The thermal pad is not connected internally. There is no requirement to electrically connect this pad. If connected, however, it is recommended that the pad be left floating or tied to GND. |

表 4-1. Pin Functions

(1) I = input, O = output, P = power

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1) (2)

| | | MIN | MAX | UNIT |
|---|--|-----------------------|---------------------------------------|------|
| V _{DD} - V _{SS} | | | 48 | V |
| V _{DD} | Supply voltage | - 0.5 | 48 | V |
| V _{SS} | _ | - 48 | 0.5 | V |
| V_{SEL} or V_{EN} | Logic control input pin voltage (SELx) | - 0.5 | 48 | V |
| I _{SEL} or I _{EN} | Logic control input pin current (SELx) | - 30 | 30 | mA |
| V_S or V_D | Source or drain voltage (Sx, Dx) | V _{SS} - 0.5 | V _{DD} +0.5 | V |
| I _{IK} | Diode clamp current ⁽³⁾ | - 30 | 30 | mA |
| I _S or I _{D (CONT)} | Source or drain continuous current (Sx, Dx) | | I _{DC} + 10 % ⁽⁴⁾ | mA |
| T _A | Ambient temperature | - 55 | 150 | °C |
| T _{stg} | Storage temperature | - 65 | 150 | °C |
| TJ | Junction temperature | | 150 | °C |
| P _{tot} | Total power dissipation (QFN) ⁽⁵⁾ | | 1650 | mW |
| P _{tot} | Total power dissipation (TSSOP) ⁽⁵⁾ | | 720 | mW |

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) All voltages are with respect to ground, unless otherwise specified.

(3) Pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.

(4) Refer to Source or Drain Continuous Current table for I_{DC} specifications.

(5) For QFN package: P_{tot} derates linearly above $T_A = 70^{\circ}$ C by 24.2mW/°C.

5.2 ESD Ratings

| | | | VALUE | UNIT |
|-------|-------------------------|---|-------|------|
| 1 | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins ⁽¹⁾ | ±1000 | V |
| (ESD) | | Charged device model (CDM), per ANSI/ESDA/ JEDEC JS-002, all pins ⁽²⁾ | ±500 | v |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



5.3 Thermal Information

| | | TMU | | |
|------------------------|--|------------|------------|------|
| | THERMAL METRIC ⁽¹⁾ | RUM (WQFN) | PW (TSSOP) | UNIT |
| | | 16 PINS | 16 PINS | |
| R _{0 JA} | Junction-to-ambient thermal resistance | 41.5 | 97.1 | °C/W |
| R _{0 JC(top)} | Junction-to-case (top) thermal resistance | 25.1 | 25.6 | °C/W |
| R _{0 JB} | Junction-to-board thermal resistance | 16.5 | 44.1 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 0.3 | 1.1 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 16.4 | 43.4 | °C/W |
| R _{0 JC(bot)} | Junction-to-case (bottom) thermal resistance | 2.9 | N/A | °C/W |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | MIN | NOM MAX | UNIT |
|------------------------------|--|-----------------|--------------------------------|------|
| $V_{DD} - V_{SS}$ (1) | Power supply voltage differential | 4.5 | 44 | V |
| V _{DD} | Positive power supply voltage | 4.5 | 44 | V |
| $V_{S} \text{ or } V_{D}$ | Signal path input/output voltage (source or drain pin) (Sx, D) | V _{SS} | V _{DD} | V |
| V_{SEL} or V_{EN} | Address or enable pin voltage | 0 | 44 | V |
| $I_S \text{ or } I_D (CONT)$ | Source or drain continuous current (Sx, D) | | I _{DC} ⁽²⁾ | mA |
| T _A | Ambient temperature | - 40 | 125 | °C |

 V_{DD} and V_{SS} can be any value as long as 4.5 V \leqslant (V_{DD} $\,-\,$ V_{SS}) \leqslant 44 V, and the minimum V_{DD} is met. Refer to *Source or Drain Continuous Current* table for I_{DC} specifications. (1)

(2)

5.5 Source or Drain Continuous Current

at supply voltage of V_{DD} ± 10%, V_{SS} ± 10 % (unless otherwise noted)

| CONTINU | OUS CURRENT PER CHANNEL (I _{DC}) ⁽²⁾ | T _A = 25°C | T _A = 85°C | T₄ = 125°C | UNIT |
|------------|---|-----------------------|-----------------------|------------------------|------|
| PACKAGE | TEST CONDITIONS | T _A = 25 C | 1 _A = 85 C | 1 _A = 125 C | UNIT |
| | +44 V Dual Supply ⁽¹⁾ | 470 | 300 | 165 | mA |
| PW (TSSOP) | ±15 V Dual Supply | 455 | 300 | 165 | mA |
| FW (1330F) | +12 V Single Supply | 355 | 240 | 145 | mA |
| | ±5 V Dual Supply | 335 | 225 | 140 | mA |
| | +44 V Single Supply ⁽¹⁾ | 650 | 400 | 180 | mA |
| | ±15 V Dual Supply | 650 | 400 | 180 | mA |
| RUM (WQFN) | +12 V Single Supply | 500 | 310 | 170 | mA |
| | ±5 V Dual Supply | 450 | 290 | 160 | mA |

Specified for nominal supply voltage only. (1)

(2) Refer to Total power dissipation (Ptot) limits in Absolute Maximum Ratings table that must be followed with max continuous current specification.



5.6 ±15 V Dual Supply: Electrical Characteristics

 $\label{eq:VDD} \begin{array}{l} V_{DD} = +15 \ V \pm 10\%, \ V_{SS} = -15 \ V \pm 10\%, \ GND = 0 \ V \ (unless \ otherwise \ noted) \\ Typical \ at \ V_{DD} = +15 \ V, \ V_{SS} = -15 \ V, \ T_A = 25 \ \ \ \ (unless \ otherwise \ noted) \end{array}$

| | PARAMETER | TEST CONDITIONS | TA | MIN | TYP | MAX | UNIT |
|--|--|---|------------------|--|---------|---|------|
| ANALOG | SWITCH | · · | | | | | |
| | | $V_{\rm S}$ = -10 V to +10 V | 25°C | | 2 | 2.7 | Ω |
| R _{ON} | On-resistance | I _D = - 10 mA | - 40°C to +85°C | | | 3.4 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 2 2.7 3.4 4 1 0.18 0.19 0.21 2 0.46 0.65 0.7 8 0 5 0.25 3 20 1 0.6 7 45 5 0.25 3 20 44 0.8 44 2 5 5 5 5 5 5 65 65 80 80 | Ω |
| | | V _S = - 10 V to +10 V | 25°C | | 0.1 | 0.18 | Ω |
| ΔR_{ON} | On-resistance mismatch between channels | L = 10 mA | - 40°C to +85°C | | | 0.19 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | $\begin{array}{c c c c c c c c c c c c c c c c c c c $ | Ω | | |
| | | V _S = - 10 V to +10 V | 25°C | | 0.2 | 0.46 | Ω |
| R _{ON FLAT} | On-resistance flatness | $I_{\rm S} = -10 \rm{mA}$ | - 40°C to +85°C | | | 0.65 | Ω |
| | N DRIFT On-resistance drift | Refer to On-Resistance | - 40°C to +125°C | | | 0.7 | Ω |
| R _{ON DRIFT} | On-resistance drift | V _S = 0 V, I _S = - 10 mA Refer to On-Resistance | - 40°C to +125°C | | 0.008 | | Ω/°C |
| | | V _{DD} = 16.5 V, V _{SS} = -16.5 V | 25°C | - 0.25 | 0.05 | 0.25 | nA |
| I _{S(OFF)} | Source off leakage current ⁽¹⁾ | Switch state is off $V_S = +10 V / -10 V$ | - 40°C to +85°C | - 3 | | 3 | nA |
| ·3(0FF) | | $V_D = -10 V / + 10 V$ Refer to Off-Leakage Current | - 40°C to +125°C | - 20 | | 20 | nA |
| | | V _{DD} = 16.5 V, V _{SS} = - 16.5 V | 25°C | - 0.6 | 0.1 | 0.6 | nA |
| I _{D(OFF)} Drain off | Drain off leakage current ⁽¹⁾ | Switch state is off $V_S = +10 V / -10 V$ $V_D = -10 V / +10 V$ Refer to Off-Leakage Current | - 40°C to +85°C | - 7 | | 7 | nA |
| ·D(OFF) | | | - 40°C to +125°C | - 45 | | 45 | nA |
| | | V_{DD} = 16.5 V, V_{SS} = -16.5 V Switch state is on V_S = V_D = ±10 V | 25°C | - 0.25 | 0.05 | 0.25 | nA |
| I _{S(ON)} I _{D(ON)} | Channel on leakage current ⁽²⁾ | | - 40°C to +85°C | - 3 | | 3 | nA |
| D(ON) | | Refer to On-Leakage Current | - 40°C to +125°C | - 20 | | 20 | nA |
| LOGIC INF | PUTS (SEL / EN pins) | | | | | I | |
| V _{IH} | Logic voltage high | | - 40°C to +125°C | 1.3 | | 44 | V |
| V _{IL} | Logic voltage low | | - 40°C to +125°C | 0 | | 0.8 | V |
| I _{IH} | Input leakage current | | - 40°C to +125°C | | 0.4 | 2 | μA |
| IIL | Input leakage current | | - 40°C to +125°C | - 1.5 | - 0.005 | | μA |
| C _{IN} | Logic input capacitance | | - 40°C to +125°C | | 3.5 | | pF |
| POWER S | UPPLY | | 1 | - | | | |
| | | | 25°C | | 35 | 56 | μA |
| I _{DD} | V _{DD} supply current | V_{DD} = 16.5 V, V_{SS} = - 16.5 V Logic inputs = 0 V, 5 V, or V_{DD} | - 40°C to +85°C | | | 65 | μA |
| | | | - 40°C to +125°C | | | 80 | μA |
| | | | 25°C | | 5 | 20 | μA |
| I _{SS} | V _{SS} supply current | V_{DD} = 16.5 V, V_{SS} = - 16.5 V Logic inputs = 0 V, 5 V, or V_{DD} | - 40°C to +85°C | | | 24 | μA |
| | | | - 40°C to +125°C | | | 35 | μA |

When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive. (1)

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.



5.7 ±15 V Dual Supply: Switching Characteristics

 V_{DD} = +15 V ± 10%, V_{SS} = - 15 V ± 10%, GND = 0 V (unless otherwise noted) Typical at V_{DD} = +15 V, V_{SS} = - 15 V, T_A = 25°C (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | TA | MIN TY | P MAX | UNIT |
|---|--|--|------------------|--------|--|------|
| | | V _S = 10 V | 25°C | 11 | 0 125 | ns |
| TRAN | Transition time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 140 | ns |
| | | Refer to Transition Time | - 40°C to +125°C | | 110 125 | ns |
| | | V _S = 10 V | 25°C | g | 5 120 | ns |
| t _{ON} | Turn-on time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 135 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | 145 | ns |
| | | V _S = 10 V | 25°C | 12 | 5 160 | ns |
| OFF | Turn-off time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 175 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | 190 | ns |
| | | V _S = 10 V, | 25°C | 2 | 7 | ns |
| BBM | Break-before-make time delay | R_L = 300 Ω , C_L = 35 pF | - 40°C to +85°C | 5 | | ns |
| | | Refer to Break-before-make Time | - 40°C to +125°C | 5 | 110 125 140 155 95 120 135 145 145 145 125 160 125 160 125 160 125 160 125 160 125 160 0.17 190 27 1 0.17 0.18 0.18 1 720 1 30 1 -70 1 -50 1 -93 1 40 1 -0.15 1 -68 1 0.0006 1 45 55 | ns |
| | | V _{DD} rise time = 1 µs | 25°C | 0.1 | 7 | ms |
| ON (VDD) | Device turn on time (V _{DD} to output) | $R_{L} = 300 \ \Omega$, $C_{L} = 35 \ pF$ | - 40°C to +85°C | 0.1 | $ \begin{array}{c ccccc} 110 & 125 \\ 140 \\ 155 \\ 95 & 120 \\ 135 \\ 145 \\ 125 & 160 \\ 175 \\ 190 \\ 27 \\ 5 \\ 5 \\ 0.17 \\ 0.18 \\ 0.18 \\ 0.18 \\ 0.18 \\ 720 \\ 30 \\ - 70 \\ - 50 \\ - 70 \\ - 50 \\ - 107 \\ - 93 \\ 40 \\ - 0.15 \\ - 68 \\ 0.0006 \\ 45 \\ \end{array} $ | ms |
| | | Refer to Turn-on (VDD) Time | - 40°C to +125°C | 0.1 | | ms |
| t _{PD} | Propagation delay | $R_L = 50 \Omega$, $C_L = 5 pF$ Refer to Propagation Delay | 25°C | 72 | 0 | ps |
| Q _{INJ} | Charge injection | V _S = 0 V, C _L = 100 pF Refer to Charge Injection | 25°C | 3 | 0 | pC |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 0 \ V, \ f = 100 \ kHz \\ Refer to \ Off \ Isolation \end{array} $ | 25°C | - 7 | 0 | dB |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 0 \ V, \ f = 1 \ MHz \\ Refer \ to \ Off \ Isolation \end{array} $ | 25°C | - 5 | 0 | dB |
| X _{TALK} | Crosstalk | R_L = 50 Ω , C_L = 5 pF Vs = 0 V, f = 100 kHz Refer to Crosstalk | 25°C | - 10 | 7 | dB |
| X _{TALK} | Crosstalk | R_L = 50 Ω , C_L = 5 pF V _S = 0 V, f = 1 MHz Refer to Crosstalk | 25°C | – ç | 3 | dB |
| BW | - 3dB Bandwidth | $R_L = 50 Ω$, $C_L = 5 pF$ $V_S = 0 V$ Refer to Bandwidth | 25°C | 4 | 0 | MHz |
| IL | Insertion loss | R_{L} = 50 Ω , C_{L} = 5 pF V_{S} = 0 V, f = 1 MHz | 25°C | - 0.1 | 5 | dB |
| ACPSRR | AC Power Supply Rejection Ratio | $\label{eq:VP} \begin{array}{l} V_{PP} = 0.62 \ V \ \text{on} \ V_{DD} \ \text{and} \ V_{SS} \\ R_L = 50 \ \Omega \ , \ C_L = 5 \ \text{pF}, \\ f = 1 \ \text{MHz} \\ \text{Refer to} \ \text{ACPSRR} \end{array}$ | 25°C | - 6 | 8 | dB |
| THD+N | Total Harmonic Distortion + Noise | $\label{eq:VPP} \begin{array}{l} V_{PP} = 15 \ V, \ V_{BIAS} = 0 \ V \\ R_L = 10 \ k \ \Omega \ , \ C_L = 5 \ pF, \\ f = 20 \ Hz \ to \ 20 \ kHz \\ Refer \ to \ THD + Noise \end{array}$ | 25°C | 0.000 | 6 | % |
| C _{S(OFF)} | Source off capacitance | V _S = 0 V, f = 1 MHz | 25°C | 4 | 5 | pF |
| CD(OFF) | Drain off capacitance | V _S = 0 V, f = 1 MHz | 25°C | 5 | 5 | pF |
| C _{S(ON),} C _{D(ON)} | On capacitance | V _S = 0 V, f = 1 MHz | 25°C | 16 | 5 | pF |



5.8 ±20 V Dual Supply: Electrical Characteristics

 $V_{DD} = +20 \text{ V} \pm 10\%, V_{SS} = -20 \text{ V} \pm 10\%, \text{ GND} = 0 \text{ V} \text{ (unless otherwise noted)}$ Typical at $V_{DD} = +20 \text{ V}, V_{SS} = -20 \text{ V}, T_A = 25 ^{\circ}\text{C}$ (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | TA | TYP | MAX | UNIT | |
|--|--|---|------------------|-------|---------|------|------|
| ANALOG | SWITCH | 1 | | | | I | |
| | | V _S = - 15 V to +15 V | 25°C | | 1.7 | 2.5 | Ω |
| R _{ON} | On-resistance | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 3.2 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 3.8 | Ω |
| | | V _S = - 15 V to +15 V | 25°C | | 0.1 | 0.18 | Ω |
| ΔR_{ON} | On-resistance mismatch between channels | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 0.19 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 0.21 | Ω |
| | | V _S = - 15 V to +15 V | 25°C | | 0.3 | 0.6 | Ω |
| R _{ON FLAT} | On-resistance flatness | I _S = - 10 mA | - 40°C to +85°C | | | 0.8 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 0.95 | Ω |
| R _{ON DRIFT} | On-resistance drift | $V_S = 0 V$, $I_S = -10 mA$ Refer to On-Resistance | - 40°C to +125°C | | 0.008 | | Ω/°C |
| | | V _{DD} = 22 V, V _{SS} = -22 V | 25°C | - 1 | 0.05 | 1 | nA |
| I _{S(OFF)} | Source off leakage current ⁽¹⁾ | Switch state is off $V_S = +15 V / - 15 V$ | - 40°C to +85°C | - 4.5 | | 4.5 | nA |
| ·3(0FF) | | V _D = - 15 V / + 15 V Refer to Off-Leakage Current | - 40°C to +125°C | - 33 | | 33 | nA |
| | | V _{DD} = 22 V, V _{SS} = -22 V | 25°C | - 2.2 | 0.22 | 2.2 | nA |
| D(OFF) | Drain off leakage current ⁽¹⁾ | Switch state is off $V_S = +15 V / - 15 V$ | - 40°C to +85°C | - 10 | | 10 | nA |
| ·D(OFF) | | V _D = - 15 V / + 15 V Refer to Off-Leakage Current | - 40°C to +125°C | - 70 | | 70 | nA |
| | | V _{DD} = 22 V, V _{SS} = - 22 V | 25°C | - 1 | 0.05 | 1 | nA |
| I _{S(ON)} I _{D(ON)} | Channel on leakage current ⁽²⁾ | Switch state is on $V_S = V_D = \pm 15 V$ | - 40°C to +85°C | - 4.5 | | 4.5 | nA |
| D(ON) | | Refer to On-Leakage Current | - 40°C to +125°C | - 33 | | 33 | nA |
| LOGIC INF | PUTS (SEL / EN pins) | 1 | | | | I | |
| V _{IH} | Logic voltage high | | - 40°C to +125°C | 1.3 | | 44 | V |
| V _{IL} | Logic voltage low | | - 40°C to +125°C | 0 | | 0.8 | V |
| I _{IH} | Input leakage current | | - 40°C to +125°C | | 0.4 | 2 | μA |
| IIL | Input leakage current | | - 40°C to +125°C | - 1.2 | - 0.005 | | μA |
| C _{IN} | Logic input capacitance | | - 40°C to +125°C | | 3.5 | | pF |
| POWER S | UPPLY | | | - | | | |
| | | | 25°C | | 33 | 65 | μA |
| I _{DD} | V _{DD} supply current | V_{DD} = 22 V, V_{SS} = -22 V Logic inputs = 0 V, 5 V, or V_{DD} | - 40°C to +85°C | | | 74 | μA |
| | | | - 40°C to +125°C | | | 90 | μA |
| | | | 25°C | | 7 | 26 | μA |
| I _{SS} | V _{SS} supply current | V_{DD} = 22 V, V_{SS} = -22 V Logic inputs = 0 V, 5 V, or V_{DD} | - 40°C to +85°C | | | 30 | μA |
| | | | - 40°C to +125°C | | | 45 | μA |

When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive. (1)

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.



5.9 ±20 V Dual Supply: Switching Characteristics

 $V_{DD} = +20 \text{ V} \pm 10\%, V_{SS} = -20 \text{ V} \pm 10\%, \text{ GND} = 0 \text{ V} \text{ (unless otherwise noted)}$ Typical at $V_{DD} = +20 \text{ V}, V_{SS} = -20 \text{ V}, T_A = 25^{\circ}\mathbb{C}$ (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | T _A | MIN TY | P MAX | UNIT |
|---|--|---|------------------|--------|--------|------|
| | | V _S = 10 V | 25°C | 10 | 00 160 | ns |
| TRAN | Transition time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 170 | ns |
| | | Refer to Transition Time | - 40°C to +125°C | | 180 | ns |
| | | V _S = 10 V | 25°C | 9 | 95 140 | ns |
| t _{ON} | Turn-on time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 160 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | 180 | ns |
| | | V _S = 10 V | 25°C | 1: | 25 150 | ns |
| OFF | Turn-off time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 165 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | 190 | ns |
| | | V _S = 10 V, | 25°C | | 28 | ns |
| BBM | Break-before-make time delay | $R_L = 300 \Omega$, $C_L = 35 pF$ | - 40°C to +85°C | 5 | | ns |
| | | Refer to Break-before-make Time | - 40°C to +125°C | 5 | | ns |
| | | V _{DD} rise time = 1 µs | 25°C | 0. | 17 | ms |
| ON (VDD) | Device turn on time (V _{DD} to output) | $R_{L} = 300 \ \Omega$, $C_{L} = 35 \ pF$ | - 40°C to +85°C | 0. | 18 | ms |
| | | Refer to Turn-on (VDD) Time | - 40°C to +125°C | 0. | 18 | ms |
| t _{PD} | Propagation delay | $R_L = 50 \ \Omega$, $C_L = 5 \text{ pF}$ Refer to Propagation Delay | 25°C | 74 | 10 | ps |
| Q _{INJ} | Charge injection | $V_S = 0 V, C_L = 100 pF$ Refer to Charge Injection | 25°C | | 15 | рС |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 0 \ V, \ f = 100 \ kHz \\ Refer to \ Off \ Isolation \end{array} $ | 25°C | | 70 | dB |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 0 \ V, \ f = 1 \ MHz \\ Refer to \ Off \ Isolation \end{array} $ | 25°C | - (| 50 | dB |
| X _{TALK} | Crosstalk | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 0 \ V, \ f = 100 \ kHz \\ Refer to Crosstalk \end{array} $ | 25°C | - 10 |)7 | dB |
| X _{TALK} | Crosstalk | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 0 \ V, \ f = 1 \ MHz \\ Refer to Crosstalk \\ \end{array} $ | 25°C | - (| 93 | dB |
| BW | - 3dB Bandwidth | $R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$ Refer to Bandwidth | 25°C | | 35 | MHz |
| L | Insertion loss | R_{L} = 50 Ω , C_{L} = 5 pF V_{S} = 0 V, f = 1 MHz | 25°C | - 0. | 14 | dB |
| ACPSRR | AC Power Supply Rejection Ratio | $\label{eq:VPP} \begin{array}{l} V_{PP} = 0.62 \ V \ \text{on} \ V_{DD} \ \text{and} \ V_{SS} \\ R_L = 50 \ \Omega \ , \ C_L = 5 \ \text{pF}, \\ f = 1 \ \text{MHz} \\ \text{Refer to} \ \text{ACPSRR} \end{array}$ | 25°C | - (| 8 | dB |
| THD+N | Total Harmonic Distortion + Noise | $\label{eq:VPP} \begin{array}{l} V_{PP} = 20 \ V, \ V_{BIAS} = 0 \ V \\ R_{L} = 10 \ k \Omega \ , \ C_{L} = 5 \ pF, \\ f = 20 \ Hz \ to \ 20 \ kHz \\ Refer \ to \ THD \ + \ Noise \end{array}$ | 25°C | 0.000 | 06 | % |
| C _{S(OFF)} | Source off capacitance | V _S = 0 V, f = 1 MHz | 25°C | | 45 | pF |
| C _{D(OFF)} | Drain off capacitance | V _S = 0 V, f = 1 MHz | 25°C | | 55 | pF |
| C _{S(ON),} C _{D(ON)} | On capacitance | V _S = 0 V, f = 1 MHz | 25°C | 10 | 35 | pF |



5.10 44 V Single Supply: Electrical Characteristics

V_{DD} = +44 V, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)

Typical at V_{DD} = +44 V, V_{SS} = 0 V, T_A = 25°C (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | TEST CONDITIONS T _A | | | | UNIT |
|--|--|---|--------------------------------|-------|---------|------|------|
| ANALOG | SWITCH | l | | | | | |
| | | $V_{S} = 0 V \text{ to } 40 V$ | 25°C | | 2 | 2.4 | Ω |
| R _{ON} | On-resistance | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 3.2 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 3.8 | Ω |
| | | $V_{\rm S}$ = 0 V to 40 V | 25°C | | 0.1 | 0.18 | Ω |
| ΔR_{ON} | On-resistance mismatch between channels | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 0.19 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 0.21 | Ω |
| | | $V_{\rm S} = 0 V$ to 40 V | 25°C | | 0.65 | 0.8 | Ω |
| R _{ON FLAT} | On-resistance flatness | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 1.1 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 1.2 | Ω |
| R _{ON DRIFT} | On-resistance drift | V _S = 22 V, I _S = - 10 mA Refer to On-Resistance | - 40°C to +125°C | | 0.007 | | Ω/°C |
| | | V _{DD} = 44 V, V _{SS} = 0 V | 25°C | - 1 | 0.05 | 1 | nA |
| I _{S(OFF)} | Source off leakage current ⁽¹⁾ | Switch state is off V _S = 40 V / 1 V | - 40°C to +85°C | - 7 | | 7 | nA |
| | | $V_D = 1 V / 40 V$ Refer to Off-Leakage Current | - 40°C to +125°C | - 50 | | 50 | nA |
| | | $V_{DD} = 44 \text{ V}, V_{SS} = 0 \text{ V}$ | 25°C | - 2.2 | 0.12 | 2.2 | nA |
| I _{D(OFF)} | Drain off leakage current ⁽¹⁾ | Switch state is off V _S = 40 V / 1 V | - 40°C to +85°C | - 15 | | 15 | nA |
| _() | | $V_D = 1 V / 40 V$ Refer to Off-Leakage Current | - 40°C to +125°C | - 115 | | 115 | nA |
| | | V _{DD} = 44 V, V _{SS} = 0 V | 25°C | - 1 | 0.05 | 1 | nA |
| I _{S(ON)} I _{D(ON)} | Channel on leakage current ⁽²⁾ | Switch state is on $V_S = V_D = 40$ V or 1 V | - 40°C to +85°C | - 7 | | 7 | nA |
| D(ON) | | Refer to On-Leakage Current | - 40°C to +125°C | - 50 | | 50 | nA |
| LOGIC INF | PUTS (SEL / EN pins) | | | | | | |
| V _{IH} | Logic voltage high | | - 40°C to +125°C | 1.3 | | 44 | V |
| V _{IL} | Logic voltage low | | - 40°C to +125°C | 0 | | 0.8 | V |
| I _{IH} | Input leakage current | | - 40°C to +125°C | | 1 | 2.75 | μA |
| I _{IL} | Input leakage current | | - 40°C to +125°C | - 1.2 | - 0.005 | | μA |
| C _{IN} | Logic input capacitance | | - 40°C to +125°C | | 3.5 | | pF |
| POWER S | UPPLY | | | | | | |
| | | | 25°C | | 44 | 79 | μA |
| I _{DD} | V _{DD} supply current | V_{DD} = 44 V, V_{SS} = 0 V Logic inputs = 0 V, 5 V, or V_{DD} | - 40°C to +85°C | | | 88 | μA |
| | | | - 40°C to +125°C | | | 105 | μA |

(1) When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.



5.11 44 V Single Supply: Switching Characteristics

 $V_{DD} = +44 \text{ V}, \text{ V}_{SS} = 0 \text{ V}, \text{ GND} = 0 \text{ V} \text{ (unless otherwise noted)}$ Typical at V_{DD} = +44 \text{ V}, \text{ V}_{SS} = 0 \text{ V}, \text{ T}_{\text{A}} = 25 ^{\circ}\text{C} \text{ (unless otherwise noted)}

| | PARAMETER | TEST CONDITIONS | T _A | MIN | TYP | MAX | UNIT |
|---|---|---|------------------|-----|--------|-----|------|
| | | V _S = 18 V | 25°C | | 85 | 145 | ns |
| TRAN | Transition time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | | 155 | ns |
| | | Refer to Transition Time | - 40°C to +125°C | | | 185 | ns |
| | | V _S = 18 V | 25°C | | 90 | 130 | ns |
| t _{ON} | Turn-on time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | | 140 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | | 160 | ns |
| | | V _S = 18 V | 25°C | | 125 | 160 | ns |
| t _{OFF} | Turn-off time from control input | $R_L = 300 \ \Omega$, $C_L = 35 \ pF$ | - 40°C to +85°C | | | 170 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | | 180 | ns |
| | | V _S = 18 V, | 25°C | | 27 | | ns |
| t _{BBM} | Break-before-make time delay | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | 10 | | ns | |
| | | Refer to Break-before-make Time | - 40°C to +125°C | 10 | | | ns |
| | | V _{DD} rise time = 1 µs | 25°C | | 0.14 | | ms |
| t _{on (VDD)} | Device turn on time (V _{DD} to output) Propagation delay Charge injection Off-isolation Off-isolation | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 0.15 | | ms |
| | | Refer to Turn-on (VDD) Time | - 40°C to +125°C | | 0.15 | | ms |
| t _{PD} | Propagation delay | $R_L = 50 \ \Omega$, $C_L = 5 \ pF$ Refer to Propagation Delay | 25°C | | 900 | | ps |
| Q _{INJ} | Charge injection | V _S = 22 V, C _L = 100 pF Refer to Charge Injection | 25°C | | 104 | | рС |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 100 \ kHz \\ Refer to Off Isolation \end{array} $ | 25°C | | - 70 | | dB |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 1 \ MHz \\ Refer to \ Off \ Isolation \end{array} $ | 25°C | | - 50 | | dB |
| X _{TALK} | Crosstalk | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 100 \ kHz \\ Refer to Crosstalk \end{array} $ | 25°C | | - 112 | | dB |
| X _{TALK} | Crosstalk | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 1 \\ MHz \\ Refer to Crosstalk \\ \end{array} $ | 25°C | | - 93 | | dB |
| BW | - 3dB Bandwidth | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V \\ Refer to Bandwidth \end{array} $ | 25°C | | 35 | | MHz |
| IL | Insertion loss | $R_L = 50 \ \Omega$, $C_L = 5 \ pF$ $V_S = 6 \ V$, $f = 1 \ MHz$ | 25°C | | - 0.15 | | dB |
| ACPSRR | AC Power Supply Rejection Ratio | $\label{eq:VPP} \begin{array}{l} V_{PP} = 0.62 \ V \ on \ V_{DD} \ and \ V_{SS} \\ R_L = 50 \ \Omega \ , \ C_L = 5 \ pF, \\ f = 1 \ MHz \\ Refer \ to \ ACPSRR \end{array}$ | 25°C | | - 66 | | dB |
| THD+N | Total Harmonic Distortion + Noise | | 25°C | | 0.0006 | | % |
| C _{S(OFF)} | Source off capacitance | V _S = 22 V, f = 1 MHz | 25°C | | 45 | | pF |
| C _{D(OFF)} | Drain off capacitance | V _S = 22 V, f = 1 MHz | 25°C | | 55 | | pF |
| C _{S(ON),} C _{D(ON)} | On capacitance | V _S = 22 V, f = 1 MHz | 25°C | | 165 | | pF |



5.12 12 V Single Supply: Electrical Characteristics

 V_{DD} = +12 V ± 10%, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)

Typical at V_{DD} = +12 V, V_{SS} = 0 V, T_A = 25°C (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | TEST CONDITIONS T _A | | | | UNIT |
|--|--|---|--------------------------------|--------|---------|------|------|
| ANALOG | SWITCH | | | | | | |
| | | $V_{\rm S}$ = 0 V to 10 V | 25°C | | 2.8 | 5.4 | Ω |
| R _{ON} | On-resistance | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 6.8 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 7.4 | Ω |
| | | V _S = 0 V to 10 V | 25°C | | 0.13 | 0.21 | Ω |
| ΔR_{ON} | On-resistance mismatch between channels | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 0.23 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 0.25 | Ω |
| | | $V_{S} = 0 V \text{ to } 10 V$ | 25°C | | 0.8 | 1.7 | Ω |
| R _{ON FLAT} | On-resistance flatness | $I_{\rm D} = -10 {\rm mA}$ | - 40°C to +85°C | | | 1.9 | Ω |
| | | Refer to On-Resistance | - 40°C to +125°C | | | 2 | Ω |
| R _{ON DRIFT} | On-resistance drift | V _S = 6 V, I _S = - 10 mA Refer to On-Resistance | - 40°C to +125°C | | 0.015 | | Ω/°C |
| | | V _{DD} = 13.2 V, V _{SS} = 0 V | 25°C | - 0.25 | 0.01 | 0.25 | nA |
| I _{S(OFF)} | Source off leakage current ⁽¹⁾ | Switch state is off V _S = 10 V / 1 V | - 40°C to +85°C | - 2 | | 2 | nA |
| | | $V_D = 1 V / 10 V$ Refer to Off-Leakage Current | - 40°C to +125°C | - 16 | | 16 | nA |
| | | V _{DD} = 13.2 V, V _{SS} = 0 V | 25°C | - 0.6 | 0.12 | 0.6 | nA |
| I _{D(OFF)} | Drain off leakage current ⁽¹⁾ | Switch state is off V _S = 10 V / 1 V | - 40°C to +85°C | - 5 | | 5 | nA |
| _(, | | $V_D = 1 V / 10 V$ Refer to Off-Leakage Current | - 40°C to +125°C | - 34 | | 34 | nA |
| | | V _{DD} = 13.2 V, V _{SS} = 0 V | 25°C | - 0.25 | 0.01 | 0.25 | nA |
| I _{S(ON)} I _{D(ON)} | Channel on leakage current ⁽²⁾ | Switch state is on $V_S = V_D = 10 \text{ V or } 1 \text{ V}$ | - 40°C to +85°C | - 2 | | 2 | nA |
| 5(011) | | Refer to On-Leakage Current | - 40°C to +125°C | - 16 | | 16 | nA |
| LOGIC INF | PUTS (SEL / EN pins) | | | | | | |
| V _{IH} | Logic voltage high | | - 40°C to +125°C | 1.3 | | 44 | V |
| V _{IL} | Logic voltage low | | - 40°C to +125°C | 0 | | 0.8 | V |
| I _{IH} | Input leakage current | | - 40°C to +125°C | | 0.4 | 2.25 | μA |
| IIL | Input leakage current | | - 40°C to +125°C | - 1.25 | - 0.005 | | μA |
| C _{IN} | Logic input capacitance | | - 40°C to +125°C | | 3.5 | | pF |
| POWER S | UPPLY | | | | | | |
| | | | 25°C | | 30 | 44 | μA |
| I _{DD} | V _{DD} supply current | V_{DD} = 13.2 V, V_{SS} = 0 V Logic inputs = 0 V, 5 V, or V_{DD} | - 40°C to +85°C | | | 52 | μA |
| | | | - 40°C to +125°C | | | 62 | μA |

(1) When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.



5.13 12 V Single Supply: Switching Characteristics

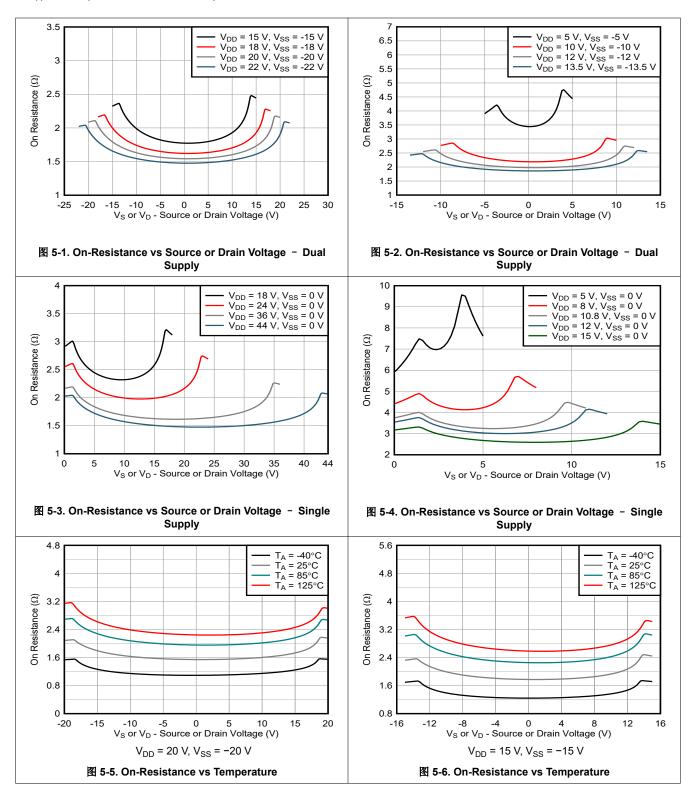
 V_{DD} = +12 V ± 10%, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)

Typical at V_{DD} = +12 V, V_{SS} = 0 V, T_A = 25 °C (unless otherwise noted)

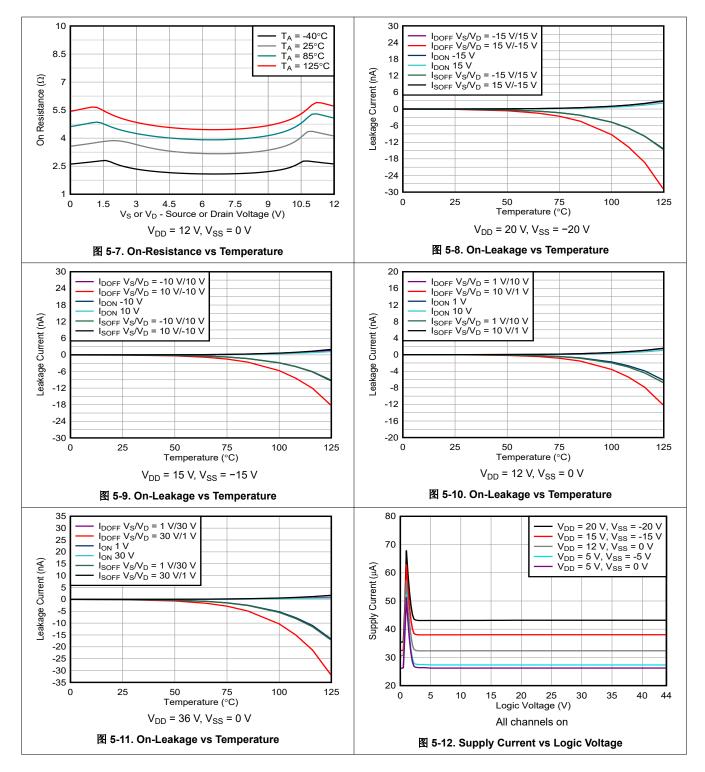
| | PARAMETER | TEST CONDITIONS | T _A | MIN | TYP | MAX | UNIT |
|--|------------------------------------|---|------------------|-----|------------------|-----|------|
| | | V _S = 8 V | 25°C | | 90 | 160 | ns |
| t _{TRAN} | Transition time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | | 190 | ns |
| | | Refer to Transition Time | - 40°C to +125°C | | | 225 | ns |
| | | V _S = 8 V | 25°C | | 190 | 235 | ns |
| t _{ON} | Turn-on time from control input | $R_{L} = 300 \ \Omega$, $C_{L} = 35 \text{ pF}$ | - 40°C to +85°C | | | 260 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | | 280 | ns |
| | | V _S = 8 V | 25°C | | 160 | 200 | ns |
| t _{OFF} | Turn-off time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | | 220 | ns |
| | | Refer to Turn-on and Turn-off Time | - 40°C to +125°C | | | 245 | ns |
| | | V _S = 8 V, | 25°C | | 30 | | ns |
| ввм | Break-before-make time delay | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | 9 | 220 245 30 | ns | |
| | | Refer to Break-before-make Time | - 40°C to +125°C | 9 | | | ns |
| | | V _{DD} rise time = 1 µs | 25°C | | 0.17 | | ms |
| t _{on (VDD)} | Turn-off time from control input | R _L = 300 Ω, C _L = 35 pF | - 40°C to +85°C | | 0.18 | | ms |
| | | Refer to Turn-on (VDD) Time | - 40°C to +125°C | | 0.18 | | ms |
| t _{PD} | Propagation delay | $R_L = 50 \ \Omega$, $C_L = 5 \ pF$ Refer to Propagation Delay | 25°C | | 770 | | ps |
| Q _{INJ} | Charge injection | $V_S = 6 V, C_L = 100 pF$ Refer to Charge Injection | 25°C | | 12 | | рС |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 100 \ kHz \\ Refer to Off Isolation \end{array} $ | 25°C | | - 70 | | dB |
| O _{ISO} | Off-isolation | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 1 \ MHz \\ Refer to \ Off \ Isolation \end{array} $ | 25°C | | - 50 | | dB |
| X _{TALK} | Crosstalk | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 100 \ kHz \\ Refer to Crosstalk \end{array} $ | 25°C | | - 112 | | dB |
| X _{TALK} | Crosstalk | $ \begin{array}{l} R_{L} = 50 \ \Omega \ , \ C_{L} = 5 \ pF \\ V_{S} = 6 \ V, \ f = 1 \\ MHz \\ Refer to Crosstalk \end{array} $ | 25°C | | - 93 | | dB |
| BW | - 3dB Bandwidth | $R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$ Refer to Bandwidth | 25°C | | 50 | | MHz |
| IL | Insertion loss | R_{L} = 50 Ω , C_{L} = 5 pF V_{S} = 6 V, f = 1 MHz | 25°C | | - 0.25 | | dB |
| ACPSRR | AC Power Supply Rejection Ratio | $\label{eq:VP} \begin{array}{l} V_{PP} = 0.62 \ V \ \text{on} \ V_{DD} \ \text{and} \ V_{SS} \\ R_L = 50 \ \Omega \ , \ C_L = 5 \ \text{pF}, \\ f = 1 \ \text{MHz} \\ \text{Refer to } \text{ACPSRR} \end{array}$ | 25°C | | - 70 | | dB |
| THD+N | Total Harmonic Distortion + Noise | $\label{eq:VPP} \begin{array}{l} V_{PP} = 6 \ V, \ V_{BIAS} = 6 \ V \\ R_{L} = 10 \ k^{\Omega} \ , \ C_{L} = 5 \ pF, \\ f = 20 \ Hz \ to \ 20 \ kHz \\ Refer \ to \ THD \ + \ Noise \end{array}$ | 25°C | | 0.001 | | % |
| C _{S(OFF)} | Source off capacitance | V _S = 6 V, f = 1 MHz | 25°C | | 52 | | pF |
| C _{D(OFF)} | Drain off capacitance | V _S = 6 V, f = 1 MHz | 25°C | | 68 | | pF |
| C _{S(ON)} , C _{D(ON)} | On capacitance | V _S = 6 V, f = 1 MHz | 25°C | | 170 | | pF |



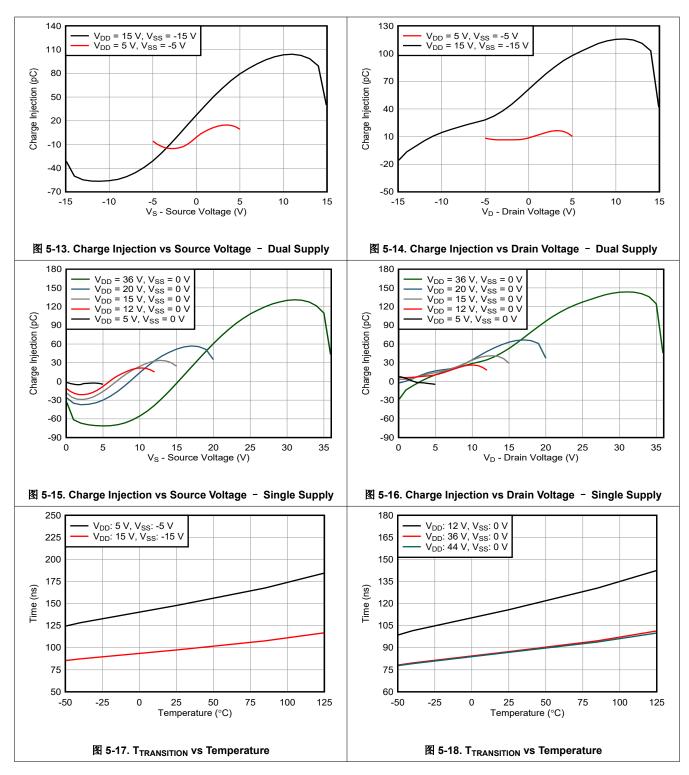
5.14 Typical Characteristics



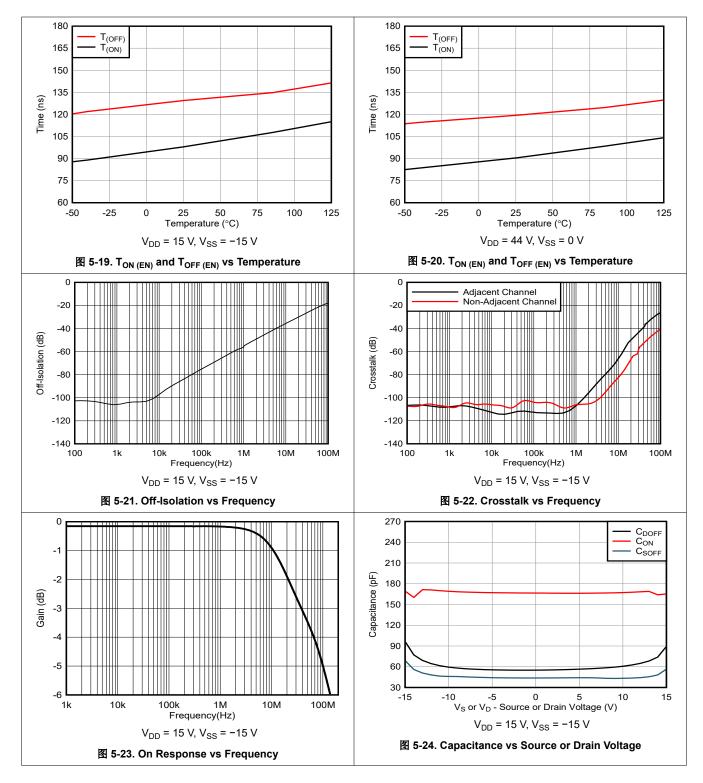






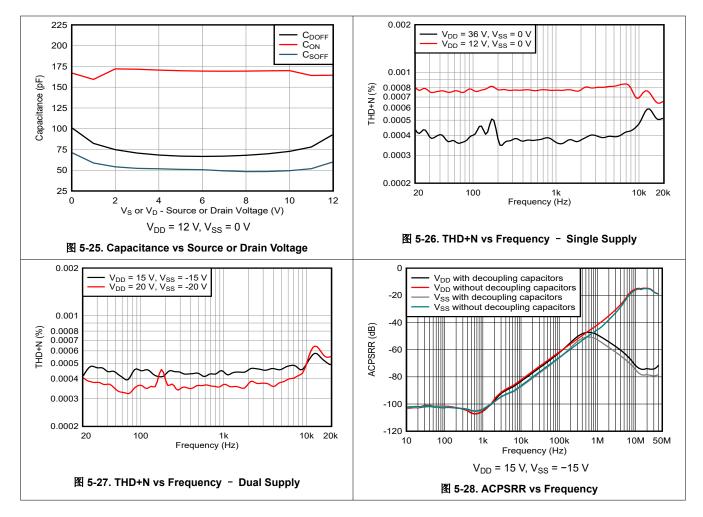








at $T_A = 25^{\circ}C$ (unless otherwise noted)





6 Parameter Measurement Information

6.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol R_{ON} is used to denote on-resistance. \mathbb{E} 6-1 shows the measurement setup used to measure R_{ON} . Voltage (V) and current (I_{SD}) are measured using this setup, and R_{ON} is computed with $R_{ON} = V / I_{SD}$.

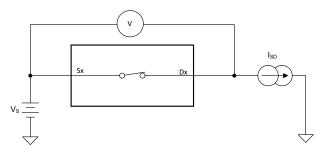


图 6-1. On-Resistance Measurement Setup

6.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

- · Source off-leakage current
- Drain off-leakage current

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol $I_{S(OFF)}$.

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol $I_{D(OFF)}$.

8 6-2 shows the setup used to measure both off-leakage currents.

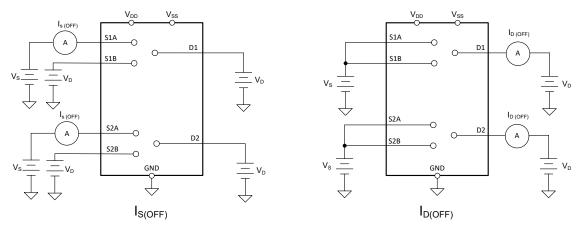


图 6-2. Off-Leakage Measurement Setup



6.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol $I_{S(ON)}$.

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol $I_{D(ON)}$.

Either the source pin or drain pin is left floating during the measurement. [4] 6-3 shows the circuit used for measuring the on-leakage current, denoted by $I_{S(ON)}$ or $I_{D(ON)}$.

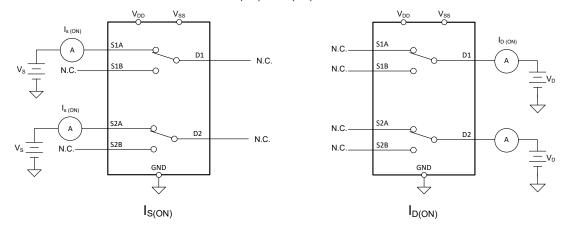


图 6-3. On-Leakage Measurement Setup

6.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 90% after the address signal has risen or fallen past the logic threshold. The 90% transition measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. \mathbb{K} 6-4 shows the setup used to measure transition time, denoted by the symbol t_{TRANSITION}.

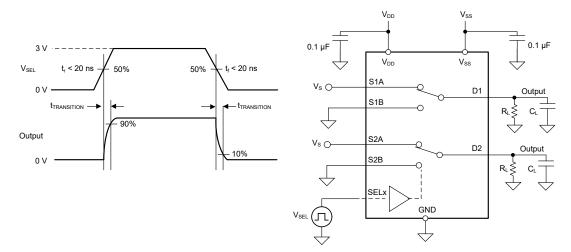


图 6-4. Transition-Time Measurement Setup



6.5 t_{ON(EN)} and t_{OFF(EN)}

Turn-on time is defined as the time taken by the output of the device to rise to 90% after the enable has risen past the logic threshold. The 90% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. \bigotimes 6-5 shows the setup used to measure turn-on time, denoted by the symbol $t_{ON(FN)}$.

Turn-off time is defined as the time taken by the output of the device to fall to 10% after the enable has fallen past the logic threshold. The 10% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. $\boxed{8}$ 6-5 shows the setup used to measure turn-off time, denoted by the symbol t_{OFF(EN)}.

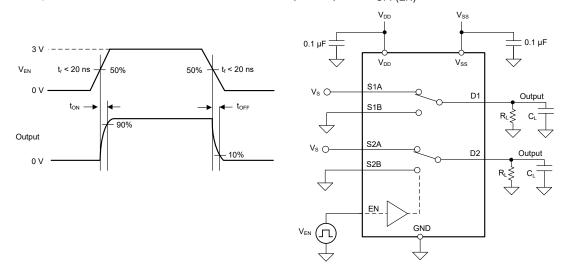
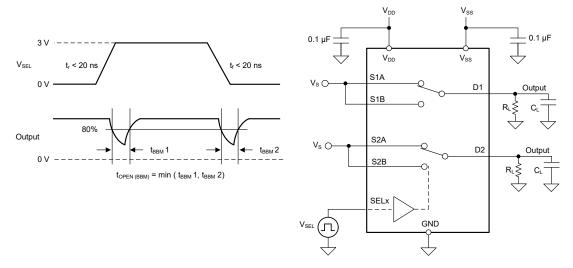


图 6-5. Turn-On and Turn-Off Time Measurement Setup

6.6 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. \boxtimes 6-6 shows the setup used to measure break-before-make delay, denoted by the symbol t_{OPEN(BBM)}.







6.7 $t_{ON (VDD)}$ Time

The $t_{ON (VDD)}$ time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is used to provide the timing of the device turning on in the system. 8 6-7 shows the setup used to measure turn on time, denoted by the symbol $t_{ON (VDD)}$.

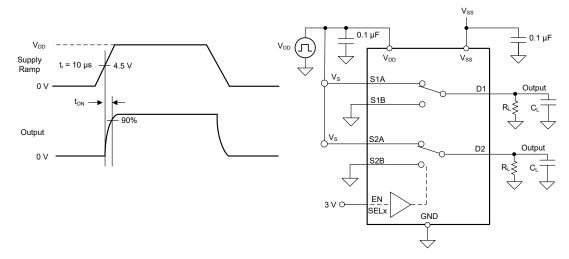


图 6-7. t_{ON (VDD)} Time Measurement Setup

6.8 Propagation Delay

Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. \mathbb{X} 6-8 shows the setup used to measure propagation delay, denoted by the symbol t_{PD}.

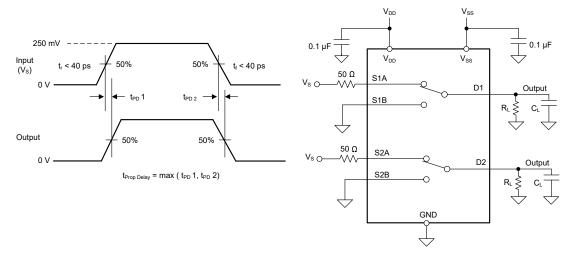


图 6-8. Propagation Delay Measurement Setup



6.9 Charge Injection

The TMUX7236 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol Q_{INJ} . \bigotimes 6-9 shows the setup used to measure charge injection from source (Sx) to drain (D).

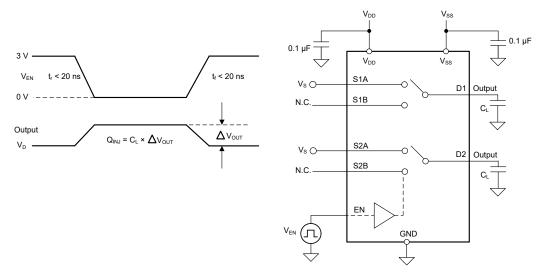


图 6-9. Charge-Injection Measurement Setup

6.10 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. \mathbb{E} 6-10 shows the setup used to measure, and the equation used to calculate off isolation.

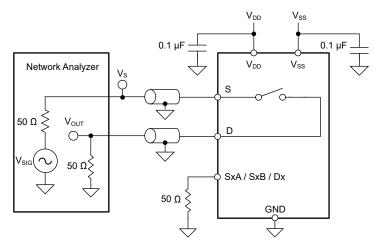


图 6-10. Off Isolation Measurement Setup



6.11 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. \boxtimes 6-11 shows the setup used to measure and the equation used to calculate crosstalk.

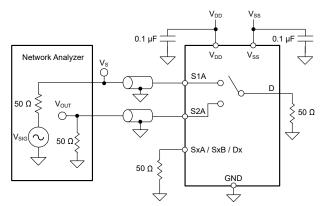


图 6-11. Crosstalk Measurement Setup

6.12 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. \boxtimes 6-12 shows the setup used to measure bandwidth.

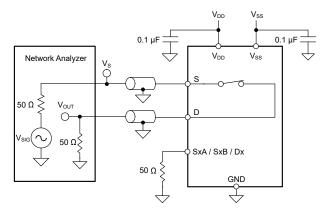


图 6-12. Bandwidth Measurement Setup



6.13 THD + Noise

The total harmonic distortion (THD) of a signal is a measurement of the harmonic distortion, and is defined as the ratio of the sum of the powers of all harmonic components to the power of the fundamental frequency at the mux output. The on-resistance of the device varies with the amplitude of the input signal and results in distortion when the drain pin is connected to a low-impedance load. Total harmonic distortion plus noise is denoted as THD.

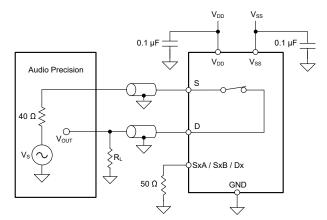


图 6-13. THD Measurement Setup

6.14 Power Supply Rejection Ratio (PSRR)

PSRR measures the ability of a device to prevent noise and spurious signals that appear on the supply voltage pin from coupling to the output of the switch. The DC voltage on the device supply is modulated by a sine wave of 620 mVPP. The ratio of the amplitude of signal on the output to the amplitude of the modulated signal is the ACPSRR. A high ratio represents a high degree of tolerance to supply rail variation.

8 6-14 shows how the decoupling capacitors reduce high frequency noise on the supply pins. This helps stabilize the supply and immediately filter as much of the supply noise as possible.

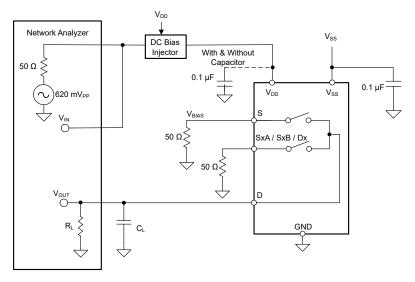


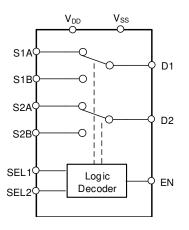
图 6-14. ACPSRR Measurement Setup



7 Detailed Description

7.1 Functional Block Diagram

The TMUX7236 is a 2:1, 2-channel multiplexer or demultiplexer. Each input is turned on or turned off based on the state of the select lines and enable pin.



7.2 Feature Description

7.2.1 Bidirectional Operation

The TMUX7236 conducts equally well from source (Sx) to drain (Dx) or from drain (Dx) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

7.2.2 Rail to Rail Operation

The valid signal path input or output voltage for TMUX7236 ranges from V_{SS} to V_{DD} .

7.2.3 1.8 V Logic Compatible Inputs

The TMUX7236 has 1.8-V logic compatible control for all logic control inputs. 1.8-V logic level inputs allows the TMUX7236 to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and bill of materials (BOM) cost. For more information on 1.8 V logic implementations, refer to *Simplifying Design with 1.8 V logic Muxes and Switches*.

7.2.4 Integrated Pull-Down Resistor on Logic Pins

The TMUX7236 has internal weak pull-down resistors to GND so that the logic pins are not left floating. The value of this pull-down resistor is approximately 4 M Ω , but is clamped to about 1 μ A at higher voltages. This feature integrates up to three external components and reduces system size and cost.

7.2.5 Fail-Safe Logic

The TMUX7236 supports Fail-Safe Logic on the control input pins (EN and SEL) allowing the device to operate up to 44 V above V_{SS} , regardless of the state of the supply pins. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the logic input pins of the TMUX7236 to be ramped to +44 V while V_{DD} and $V_{SS} = 0$ V. The logic control inputs are protected against positive faults of up to +44 V in the powered-off condition, but does not offer protection against negative overvoltage conditions.



7.2.6 Latch-Up Immune

Latch-up is a condition where a low impedance path is created between a supply pin and ground. The latch-up condition is caused by a trigger (current injection or overvoltage); but once activated, the low impedance path remains even after the trigger is no longer present. This low impedance path may cause system upset or catastrophic damage due to excessive current levels. The latch-up condition typically requires a power cycle to eliminate the low impedance path.

The TMUX7236 is constructed on silicon on insulator (SOI) based process where an oxide layer is added between the PMOS and NMOS transistor of each CMOS switch to prevent parasitic structures from forming. The oxide layer is also known as an insulating trench and prevents triggering of latch up events due to overvoltage or current injections. The latch-up immunity feature allows the TMUX7236 to be used in harsh environments. For more information on latch-up immunity, refer to *Using Latch Up Immune Multiplexers to Help Improve System Reliability*.

7.2.7 Ultra-Low Charge Injection

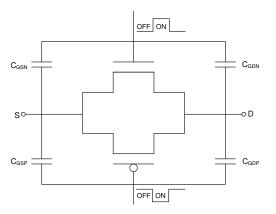


图 7-1. Transmission Gate Topology

The TMUX7236 contains specialized architecture to reduce charge injection on the Drain (Dx). To further reduce charge injection in a sensitive application, a compensation capacitor (Cp) can be added on the Source (Sx). This will push excess charge from the switch transition into the compensation capacitor on the Source (Sx) instead of the Drain (Dx). As a general rule, Cp should be 20x larger than the equivalent load capacitance on the Drain (Dx). \mathbb{X} 7-2 shows charge injection variation with different compensation capacitors on the Source side. \mathbb{X} 7-2 was captured on the TMUX7219 as part of the TMUX72xx family with a 100 pF load capacitance.

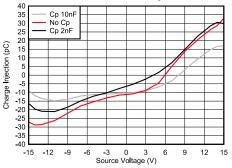


图 7-2. Charge Injection Compensation



7.3 Device Functional Modes

When the EN pin of the TMUX7236 is pulled high, one of the switches is closed based on the state of the SEL pin. When the EN pin is pulled low, both of the switches are in an open state regardless of the state of the SEL pin. The control pins can be as high as 44 V.

7.4 Truth Tables

7-1 show the truth tables for the TMUX7236.

| EN | SELx | Selected Input Connected To Drain (D) Pin |
|----|------------------|---|
| 0 | X ⁽¹⁾ | All channels are off (Hi-Z) |
| 1 | 0 | SxB |
| 1 | 1 | SxA |
| | | |

表 7-1. TMUX7236 Truth Table

(1) X denotes *do not care*.



8 Application and Implementation

备注

以下应用部分中的信息不属于 TI 元件规格, TI 不担保其准确性和完整性。TI 的客户负责确定元件是否适合其用途,以及验证和测试其设计实现以确认系统功能。

8.1 Application Information

The TMUX7236 is part of the precision switches and multiplexers family of devices. This device operates with dual supplies (\pm 4.5 V to \pm 22 V), a single supply (4.5 V and 44 V), or asymmetric supplies (such as, V_{DD} = 12 V and V_{SS} = -5 V), and offers rail-to-rail input and output. The TMUX7236 offers low R_{ON}, low on and off leakage currents and ultra-low charge injection performance. These features makes the TMUX7236 a precision, robust, high-performance analog multiplexer for high-voltage, industrial applications.

8.2 Typical Application

One application for the TMUX7236 is in data acquisition systems. For these types of input modules, accuracy and precision is key. To help account for drift over time and temperature, a calibration path is often added to calibrate the input in real time before a measurement. An SPDT switch can be used to switch in this calibration path, which the TMUX7236 is an excellent choice for. This device offers a very low on-resistance, leakage, and charge injection, which allows for a high measurement fidelity and reduces error. The break-before-make feature allows switching from the calibration path without shorting the inputs together. This device also offers on-resistance mismatch, which makes this device suitable for high precision systems. As 🕅 8-1 shows, the TMUX7236 can be used in both voltage and current acquisition.

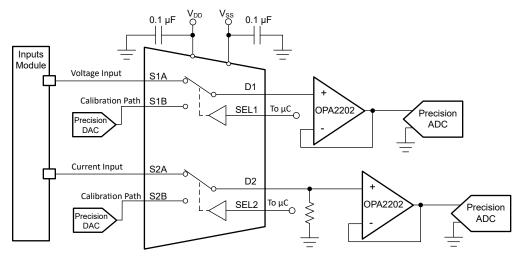


图 8-1. Data Acquisition Systems (DAQ) Calibration

8.2.1 Design Requirements

For this design example, use the parameters listed in $\frac{1}{8}$ 8-1.

| PARAMETERS | VALUES |
|---------------------------|---|
| Supply (V _{DD}) | 15 V |
| Supply (V _{SS}) | -15 V |
| MUX I/O signal range | −15 V to 15 V (Rail-to-Rail) |
| Control logic thresholds | 1.8 V compatible (up to V _{DD}) |
| EN | EN pulled high to enable the switch |

表 8-1. Design Parameters

8.2.2 Detailed Design Procedure

The TMUX7236 can operate without any external components except for the supply decoupling capacitors. All inputs passing through the switch must fall within the recommended operating conditions of the TMUX7236, including signal range and continuous current. The signal range for this design can be up to -15 V to +15 V and the maximum continuous current can be up to 330 mA for wide-range current measurement with a positive supply of 15 V on V_{DD} and negative supply of -15 V on V_{SS} (for more information, see $\ddagger 5.4$). The TMUX7236 device is a bidirectional, single-pole double-throw (SPDT) switch that offers low on-resistance, low leakage, and low power. These features make this device suitable for precision and power sensitive applications.

8.2.3 Application Curve

The low on-resistance of TMUX7236 and ultra-low charge injection performance make this device ideal for implementing high precision systems. \mathbb{E} 8-2 shows the plot for the on-resistance versus temperature. Additionally, the TMUX7236 features a very low mismatch between channels, which is important for this application because it reduces the difference between the calibration and non-calibration paths. The TMUX7236 features mismatch between channels <180 m Ω and 100 m Ω typically.

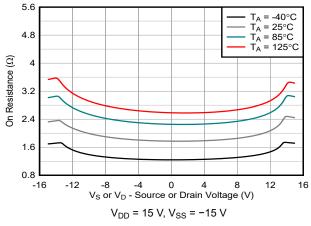


图 8-2. On-Resistance vs Temperature



8.2.3.1 On-Resistance Mismatch Between Channels

 V_{DD} = +15 V ± 10%, V_{SS} = -15 V ±10%, GND = 0 V (unless otherwise noted)

Typical at V_{DD} = +15 V, V_{SS} = -15 V, T_A = 25 °C (unless otherwise noted)

| PARA | METER | TEST CONDITIONS | T _A | MIN | TYP | MAX | UNIT |
|-------------------|------------------|--|---------------------|-----|-----|------|------|
| ∆ R _{ON} | mismatch between | | 25°C | | 0.1 | 0.18 | Ω |
| | | $V_S = -10 V$ to +10 V $I_D = -10 mA$ Refer to On-Resistance | - 40°C to +85°C | | | 0.19 | Ω |
| | | | - 40°C to +125°C | | | 0.21 | Ω |



8.3 Power Supply Recommendations

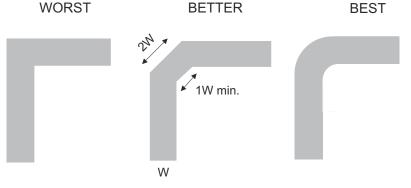
The TMUX7236 operates across a wide supply range of ± 4.5 V to ± 22 V (4.5 V to 44 V in single-supply mode). The device also performs well with asymmetrical supplies such as V_{DD} = 12 V and V_{SS}= -5 V.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the supply rails to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1 μ F to 10 μ F at both the V_{DD} and V_{SS} pins to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes. Always ensure the ground (GND) connection is established before supplies are ramped.

8.4 Layout

8.4.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. 🕅 8-3 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.





Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

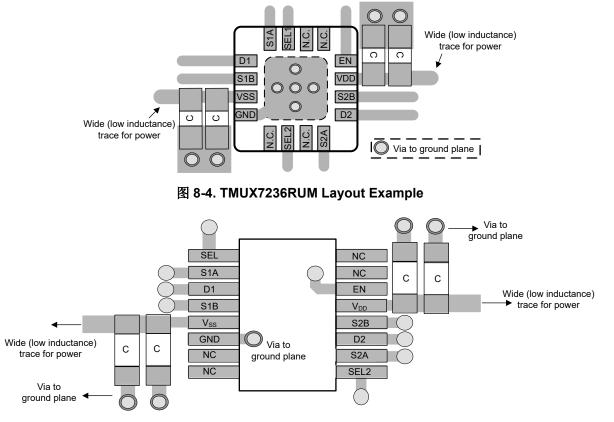
Some key considerations are as follows:

- For reliable operation, connect a decoupling capacitor ranging from 0.1 μF to 10 μF between VDD/VSS and GND. TI recommends a 0.1-μF and 1-μF capacitor, placing the lowest value capacitor as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the supply voltage.
- · Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.



• Using multiple vias in parallel will lower the overall inductance and is beneficial for connection to ground planes.

8.4.2 Layout Example







9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, Eliminate Power Sequencing with Powered-off Protection Signal Switches
- Texas Instruments, Improve Stability Issues with Low CON Multiplexers
- Texas Instruments, QFN/SON PCB Attachment
- Texas Instruments, Quad Flatpack No-Lead Logic Packages
- Texas Instruments, Simplifying Design with 1.8 V logic Muxes and Switches
- Texas Instruments, System-Level Protection for High-Voltage Analog Multiplexers
- Texas Instruments, True Differential, 4 x 2 MUX, Analog Front End, Simultaneous-Sampling ADC Circuit

9.2 接收文档更新通知

要接收文档更新通知,请导航至 ti.com 上的器件产品文件夹。点击*通知*进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

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链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范,并且不一定反映 TI 的观点;请参阅 TI 的使用条款。

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9.5 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

9.6 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序,可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级,大至整个器件故障。精密的集成电路可能更容易受到损坏,这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

10 Revision History

注:以前版本的页码可能与当前版本的页码不同

| Changes from Revision A (July 2022) to Revision B (December 2023) | Page |
|---|------|
| • 添加了 PW 封装信息 | 1 |
| | |
| Changes from Revision * (March 2022) to Revision A (July 2022) | Page |
| • 将数据表的状态从 预告信息 更改为"量产数据" | 1 |



11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|-------------------------------|----------------------|--------------|-------------------------|---------|
| TMUX7236PWR | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS & Green | (-) | Level-1-260C-UNLIM | -40 to 125 | T236 | Samples |
| TMUX7236RUMR | ACTIVE | WQFN | RUM | 16 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | TMUX T236 | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

7-May-2024

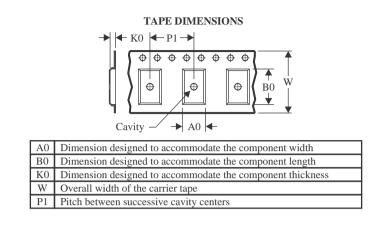


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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | | | | | | | | | | | | |
|-----------------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| TMUX7236PWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TMUX7236RUMR | WQFN | RUM | 16 | 3000 | 330.0 | 12.4 | 4.25 | 4.25 | 1.15 | 8.0 | 12.0 | Q2 |



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PACKAGE MATERIALS INFORMATION

12-Apr-2024



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TMUX7236PWR | TSSOP | PW | 16 | 2000 | 356.0 | 356.0 | 35.0 |
| TMUX7236RUMR | WQFN | RUM | 16 | 3000 | 367.0 | 367.0 | 35.0 |

PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

RUM 16

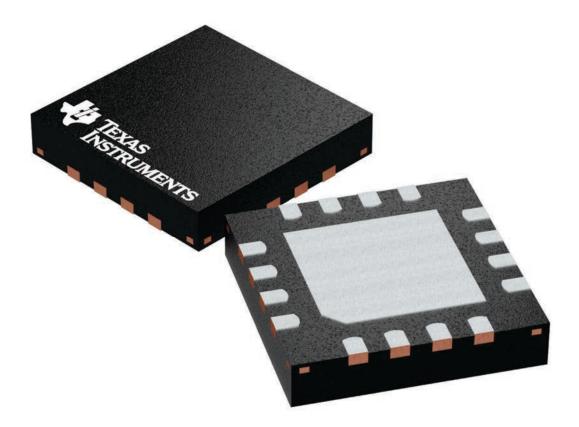
4 x 4, 0.65 mm pitch

GENERIC PACKAGE VIEW

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





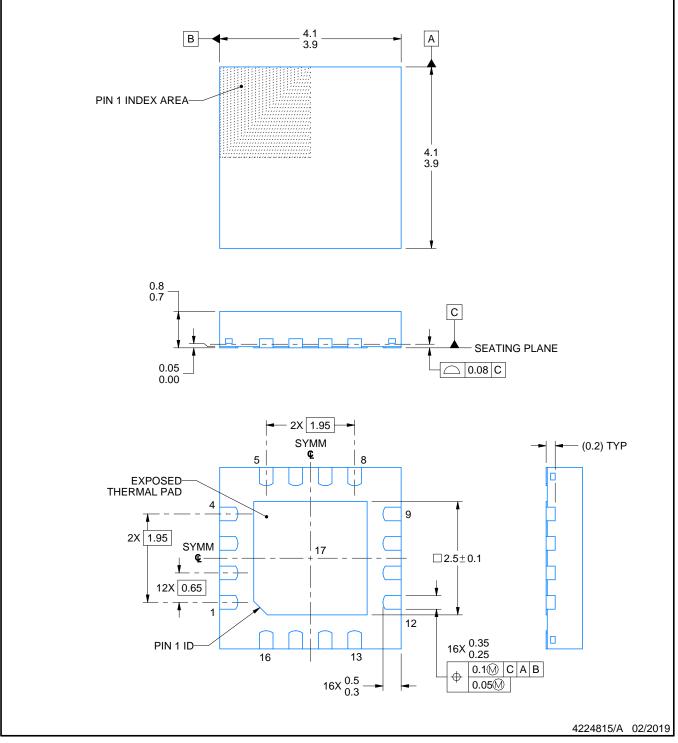
RUM0016E



PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

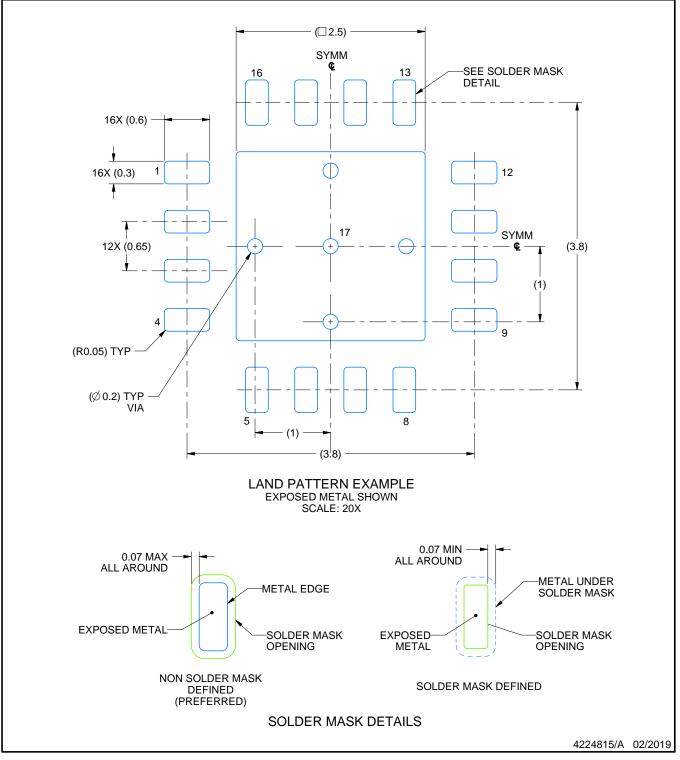


RUM0016E

EXAMPLE BOARD LAYOUT

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

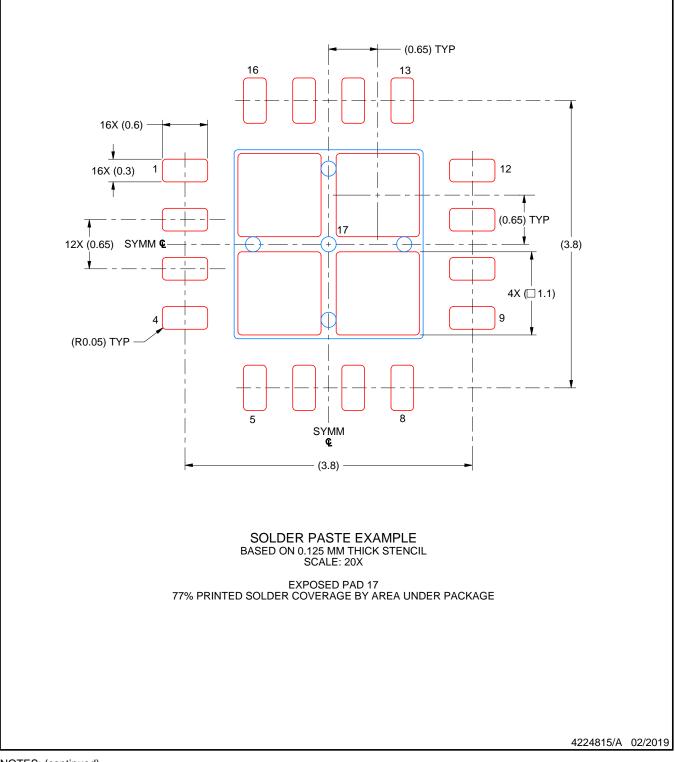


RUM0016E

EXAMPLE STENCIL DESIGN

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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